

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/650,186 LEHMAN ET AL.	
		Examiner	Art Unit JENNIFER H. GAY	3676 Page 1 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,113,621 A	12-1963	KRUEGER ROLAND F et al.	166/249
*	B	US-3,527,300 A	09-1970	PHILLIPS EDWARD H	166/249
*	C	US-4,537,256 A	08-1985	Beard, Franklin	166/299
*	D	US-4,718,774 A	01-1988	Slough, Carlton M.	374/7
*	E	US-5,092,176 A	03-1992	Buttram et al.	73/599
*	F	US-5,184,678 A	02-1993	Pechkov et al.	166/249
*	G	US-5,282,508 A	02-1994	Ellingsen et al.	166/249
*	H	US-5,377,750 A	01-1995	Arterbury et al.	166/205
*	I	US-5,458,860 A	10-1995	Morris et al.	423/155
*	J	US-5,595,243 A	01-1997	Maki et al.	166/177.2
*	K	US-5,676,213 A	10-1997	Auzerais et al.	175/58
*	L	US-5,836,389 A	11-1998	Wagner et al.	166/249
*	M	US-5,969,235 A	10-1999	Allan, Graeme	73/61.62

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/650,186 LEHMAN ET AL.	
		Examiner	Art Unit JENNIFER H. GAY	3676 Page 2 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,009,948 A	01-2000	Flanders et al.	166/301
*	B	US-6,012,521 A	01-2000	Zunkel et al.	166/249
*	C	US-6,131,659 A	10-2000	Johnson, Barry Vincent	166/250.05
*	D	US-6,220,371 B1	04-2001	Sharma et al.	175/50
*	E	US-6,227,293 B1	05-2001	Huffman et al.	166/248
*	F	US-6,230,802 B1	05-2001	Duhon, Mark	166/278
*	G	US-6,390,191 B1	05-2002	Melson et al.	166/177.1
*	H	US-2002/0070017 A1	06-2002	Soliman et al.	166/249
*	I	US-6,412,354 B1	07-2002	Birchak et al.	73/861.356
*	J	US-2002/0153135 A1	10-2002	Troutt et al.	166/249
*	K	US-2003/0085038 A1	05-2003	Restarick et al.	166/278
*	L	US-6,568,472 B1	05-2003	Gano et al.	166/207
*	M	US-6,588,505 B2	07-2003	Beck et al.	166/250.17

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/650,186 LEHMAN ET AL.	
		Examiner	Art Unit JENNIFER H. GAY	3676 Page 3 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,619,394 B2	09-2003	Soliman et al.	166/249
*	B	US-6,691,778 B2	02-2004	Cole et al.	166/249
*	C	US-6,705,396 B1	03-2004	Ivannikov et al.	166/249
*	D	US-6,814,141 B2	11-2004	Huh et al.	166/249
*	E	US-6,837,310 B2	01-2005	Martin, Andrew J.	166/297
*	F	US-6,851,444 B1	02-2005	Kohl et al.	137/13
*	G	US-2005/0028983 A1	02-2005	Lehman et al.	166/311
*	H	US-6,877,561 B2	04-2005	Richard et al.	166/278
*	I	US-6,880,402 B1	04-2005	Couet et al.	73/579
*	J	US-6,886,634 B2	05-2005	Richards, William Mark	166/278
*	K	US-6,886,406 B1	05-2005	Couet et al.	73/579
*	L	US-2005/0098319 A1	05-2005	Lehman et al.	166/304
*	M	US-6,973,972 B2	12-2005	Aronstam, Peter S.	166/311

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/650,186 LEHMAN ET AL.	
		Examiner	Art Unit JENNIFER H. GAY	3676 Page 4 of 4

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,978,831 B2	12-2005	Nguyen, Philip D.	166/250.01
*	B	US-2005/0284625 A1	12-2005	Rodney et al.	166/250.01
*	C	US-2006/0096752 A1	05-2006	Arnoldo Barrientos et al.	166/249
*	D	US-7,100,690 B2	09-2006	Mullen et al.	166/278
*	E	US-7,213,650 B2	05-2007	Lehman et al.	166/304
*	F	US-2007/0256828 A1	11-2007	Birchak et al.	166/249
*	G	US-7,318,471 B2	01-2008	Rodney et al.	166/250.01
*	H	US-7,343,970 B2	03-2008	Lopez de Cardenas et al.	166/250.07
*	I	US-7,353,869 B2	04-2008	Wetzel et al.	166/250.01
*	J	US-2010/0044032 A1	02-2010	Kabishcher et al.	166/249
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.